

OFGS P/3255-18 10/500482

APPLICANT'S ART CITATION

(Use several sheets if necessary)

Application

Applicant Sylvain DENNIEL et al.

Filing Date

Group Art Unit

U.S. PATENT DOCUMENTS

| Examiner Initial | Document Number | Date MM-YYYY | Name | Class | Sub-class | Filing Date If Appropriate |
|------------------|--------------------|--------------|---------------------|-------|-----------|----------------------------|
| NC | US-2001/0025664 A1 | 10-2001 | Quigley et al. | | | |
| NC | US-5 172 765 A | 12-1992 | Sas-Jaworsky et al. | | | |
| | US- | | | | | |
| | US- | | | | | |
| | US- | | | | | |
| | US- | | | | | |

FOREIGN PATENT DOCUMENTS

| | Document Number | Date MM-YYYY | Country | Class | Sub-class | Translation | |
|----|-----------------|--------------|---------------|-------|-----------|-------------|----|
| | | | | | | Yes | No |
| NC | WO 86/03362 | | | | | | |
| NC | 2 084 284 A | 4-1982 | Great Britain | | | | |
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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|----|--|-----------------------------|
| NC | | International Search Report |
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Examiner

Mark A. Long

Date Considered

5/9/06

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.